Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,208	WEN ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

	SEARCHED				
Class	Subclass	Date	Examiner		
205	123	2/22/2007	EW		
205	186	2/22/2007	EW		
205	210	2/22/2007	EW		
205	220	2/22/2007	EW		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		- , ,			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	2/22/2007	EW		
EAST	2/22/2007	EW		